Elektronische Bauelemente

SSG4499P

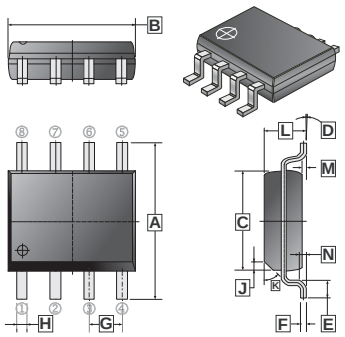
-6.8 A, -60 V, $R_{DS(ON)}$ 45 mΩ
P-Ch Enhancement Mode Power MOSFET

RoHS Compliant Product
A suffix of "-C" specifies halogen & lead-free

DESCRIPTION

These miniature surface mount MOSFETs utilize a high cell density trench process to provide low $R_{DS(on)}$ and to ensure minimal power loss and heat dissipation.

SOP-8



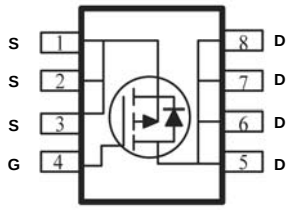
REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	5.80	6.20	H	0.35	0.49
B	4.80	5.00	J	0.375 REF.	
C	3.80	4.00	K	45°	
D	0°	8°	L	1.35	1.75
E	0.40	0.90	M	0.10	0.25
F	0.19	0.25	N	0.25 REF.	
G	1.27 TYP.				

FEATURES

- Low $R_{DS(on)}$ provides higher efficiency and extends battery life.
- Low thermal impedance copper leadframe SOP-8 saves board space.
- Fast switching speed.
- High performance trench technology.

APPLICATION

DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.



PACKAGE INFORMATION

Package	MPQ	Leader Size
SOP-8	2.5K	13' inch

MAXIMUM RATINGS (T_A = 25°C unless otherwise specified)

Parameter		Symbol	Ratings	Unit
Drain-Source Voltage		V_{DS}	-60	V
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain Current [1]	T_A = 25°C	I_D	-6.8	A
	T_A = 70°C		-6.3	A
Pulsed Drain Current [2]		I_{DM}	-30	A
Continuous Source Current (Diode Conduction) [1]		I_S	-2.5	A
Total Power Dissipation [1]	T_A = 25°C	P_D	3.1	W
	T_A = 70°C		2.6	W
Operating Junction & Storage Temperature Range		T_J, T_{STG}	-55 ~ 150	°C
Thermal Resistance Ratings				
Thermal Resistance Junction-Ambient (Max.) [1]	t ≦ 10 sec	$R_{\theta JA}$	50	°C / W

Notes:
1. Surface Mounted on 1" x 1" FR4 Board.
2. Pulse width limited by maximum junction temperature.

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Teat Conditions
Static						
Gate-Threshold Voltage	$V_{GS(th)}$	-1	-	-	V	V_{DS}= V_{GS}, I_D= -250μA
Gate-Body Leakage Current	I_{GSS}	-	-	±100	nA	V_{DS}=0, V_{GS}= ±20V
Zero Gate Voltage Drain Current	I_{DSS}	-	-	-1	μA	V_{DS}= -48V, V_{GS}=0
		-	-	-10		V_{DS}= -48V, V_{GS}=0, T_J=55°C
On-State Drain Current [1]	$I_{D(on)}$	-20	-	-	A	V_{DS}= -5V, V_{GS}= -10V
Drain-Source On-Resistance [1]	$R_{DS(ON)}$	-	-	45	mΩ	V_{GS}= -10V, I_D= -6.8A
		-	-	60		V_{GS}= -4.5V, I_D= -5.9A
Forward Transconductance [1]	g_{fs}	-	8	-	S	V_{DS}= -15V, I_D= -6.8A
Diode Forward Voltage	V_{SD}	-	-	-1.2	V	I_S= -2.5A, V_{GS}=0
Dynamic [2]						
Total Gate Charge	Q_g	-	18	-	nC	I_D= -6.8A V_{DS}= -30V V_{GS}= -4.5V
Gate-Source Charge	Q_{gs}	-	5	-		
Gate-Drain Charge	Q_{gd}	-	2	-		
Turn-On Delay Time	$T_{d(on)}$	-	8	-	nS	V_{DD}= -30V I_D= -1A V_{GEN}= -10V R_L=30Ω R_G=6Ω
Rise Time	T_r	-	10	-		
Turn-Off Delay Time	$T_{d(off)}$	-	35	-		
Fall Time	T_f	-	12	-		

Notes:
1. Pulse test：PW ≦ 300μs duty cycle ≦ 2%.
2. Guaranteed by design, not subject to production testing.